

**Search Notes**

Application/Control No.

10/726,882

Examiner

Jason M. Han

Applicant(s)/Patent under  
Reexamination

ARIK ET AL.

Art Unit

2875

**SEARCHED**

Class	Subclass	Date	Examiner
362	555, 800	2/18/2005	JMH
362	294	2/18/2005	JMH
362	373	2/18/2005	JMH
310	311	2/18/2005	JMH
310	322	2/18/2005	JMH
310	325	2/18/2005	JMH
310	328	2/18/2005	JMH
310	343	2/18/2005	JMH
310	346	2/18/2005	JMH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search Update - EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT) - See Printout	1/27/2006	JMH